

### Absolute Maximum Ratings

Exceeding the specifications below may result in permanent damage to the device, or device malfunction. Operation outside of the parameters specified in the Electrical Characteristics section is not implied. Exposure to Absolute Maximum rated conditions for extended periods of time may affect device reliability.

Parameter	Symbol	Maximum	Units
Input Supply Voltage	V <sub>IN</sub>	-0.3 to +13.2	V
Drive Pins	V <sub>DRV</sub>	-0.3 to +8.0	V
Adjust and Power Good Pins	V <sub>ADJ</sub> , V <sub>PGD</sub>	-0.3 to +5.5 <sup>(1)</sup>	V
Enable Pins	V <sub>EN</sub>	-0.3 to $V_{IN}$	V
Thermal Impedance Junction to Ambient	θ <sub>JA</sub>	113	°C/W
Thermal Impedance Junction to Case	θ <sub>JC</sub>	42	°C/W
Operating Ambient Temperature Range	T <sub>A</sub>	-40 to +85	°C
Operating Junction Temperature Range	TJ	-40 to +150	°C
Storage Temperature Range	Т <sub>stg</sub>	-65 to +150	°C
Lead Temperature (Soldering) 10 Sec.	T <sub>LEAD</sub>	300	°C
ESD Rating (Human Body Model)	ESD	2	kV

Note:

(1) Or  $V_{IN}$ , if  $V_{IN} \leq 5V$ .

# **Electrical Characteristics**

Unless specified:  $T_A = 25^{\circ}C$ ,  $V_{IN} = V_{EN} = 5V \pm 5\%$ ,  $V_{PWR}^{(1)} = 1.5V \pm 5\%$ ,  $0A \le I_{OUT} \le 3A$ . Values in **bold** apply over full operating ambient temperature range.

Parameter	Symbol	Test Conditions	Min	Тур	Мах	Units	
IN	IN I I I I I I I I I I I I I I I I I I						
Supply Voltage	V <sub>IN</sub>		4.5		13.2	V	
Quiescent Current	۱ <sub>۵</sub>	$V_{N} = 5V$		500	700	μA	
		V <sub>IN</sub> = 12V		600	900	μA	
Standby Current	I <sub>Q(OFF)</sub>	Both EN low		0.1	1.0	μA	
		Both EN low, V <sub>IN</sub> = 12V			15.0		
Undervoltage Lockout							
Start Threshold	V <sub>UVLO</sub>	$V_{\mathbb{N}}$ rising		3.75		V	
Hysteresis	V <sub>HYST</sub>	V <sub>ℕ</sub> falling		0.50		V	



#### **Electrical Characteristics (Cont.)**

Unless specified:  $T_A = 25^{\circ}$ C,  $V_{IN} = V_{EN} = 5V \pm 5\%$ ,  $V_{PWR}^{(1)} = 1.5V \pm 5\%$ ,  $0A \le I_{OUT} \le 3A$ . Values in **bold** apply over full operating ambient temperature range.

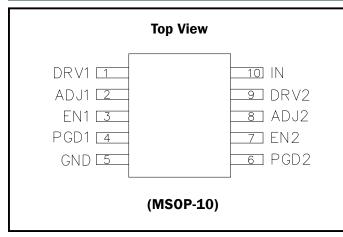
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
EN	I				L	1
Enable Input Threshold	V <sub>H</sub>	Output on	1.3			
	V	Output off			0.7	V
Enable Input Bias Current	I <sub>EN</sub>	V <sub>EN</sub> = 0V		0		μA
		$V_{IN} = V_{EN} = 5V \text{ or } 12V$	-1		+1	
ADJ						
Adjust Input Bias Current	I <sub>ADJ</sub>	V <sub>ADJ</sub> = 0.5V	-100	0	+100	nA
Reference Voltage	V <sub>ADJ</sub>		-3.5%	0.500	+3.5%	V
DRV	· · · · · ·		I			1
Output Current	I <sub>DRV</sub>	Sourcing, startup (until V <sub>TH(PGD)</sub> is reached)		10		μA
		Sourcing, after startup	0.7	2.0		mA
		Sinking	350	700		μA
Output Voltage	V <sub>DRV</sub>	Full On, $I_{DRV}$ = 0mA, $V_{IN}$ = 12V	6.6	6.9		V
		Full On, $I_{DRV}$ = 0mA, $V_{IN}$ = 5V	4.70	4.85		-
Under Voltage Protection						
Trip Threshold <sup>(1)</sup>	V <sub>TH(UV)</sub>	Measured at ADJ pin	40	50	60	%V <sub>ADJ</sub>
PGD	· · · · · ·		I			
Power Good Threshold (2)	V <sub>TH(PGD)</sub>	Measured at ADJ pin	-15	-12	-9	%V <sub>ADJ</sub>
Output Logic Low Voltage	V <sub>PGD</sub>	V <sub>ADJ</sub> = 0.4V, I <sub>PGD</sub> = -1mA			0.4	V
Power Good Leakage Current	I <sub>PGD</sub>	$V_{\text{ADJ}} = 0.5V, \ 0V \leq V_{\text{PGD}} \leq V_{\text{IN}}$	-1	0	+1	μA
Soft Start	· · ·		·			
Output Rise Time 10% V <sub>out</sub> to 90% V <sub>out</sub> V <sub>out</sub> = 1.05V	t,	C <sub>DRV-GND</sub> = not placed		150		μs
		C <sub>DRV-GND</sub> = 10nF		850		1
Error Amplifier	I I		I			1
Open Loop Gain	A <sub>VOL</sub>			52		dB
Gain Bandwidth	GBW			1		MHz

#### Notes:

(1) If  $V_{TH(UV)}$  is exceeded for longer than 50µs (nom.) the protection circuitry will shut down that output. (2) During startup only,  $V_{TH(PGD)}$  is -6% (typ.), then switches to -12% (typ.).







# Ordering Information

Part Number <sup>(1)</sup>	Output Voltage	Package	
SC2738IMSTRT <sup>(2)</sup>	Both adj. from 0.5V to 3.3V	MSOP-10	

#### Notes:

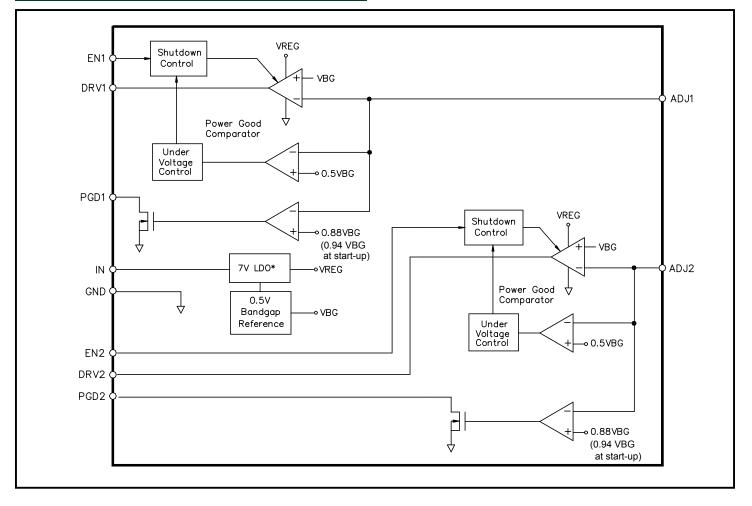
(1) Only available in tape and reel packaging. A reel contains 2500 devices.

(2) Lead free product. This product is fully WEEE and RoHS compliant.

Pin	in Descriptions					
Pin	Pin Name	Pin Function				
1	DRV1	Output of regulator #1, output impedance ~ 1k $\Omega$ . Drives the gate of an N-channel MOSFET to maintain $V_{_{OUT1}}$ set by R1 and R2.				
2	ADJ1	Regulator #1 sense input. Used for sensing the output voltage for power good and under-voltage, and to set the output voltage as follows (refer to application circuit on page 1): $V_{OUT(MAX)} = 3.3V$ for $V_{IN} = 12V$ , 1.8V for $V_{IN} = 5V$ . $V_{OUT(MAX)} = 3.3V$ for $V_{IN} = 12V$ , 1.8V for $V_{IN} = 5V$ .				
3	EN1	Active high enable control. Connect to IN if not being used. Do not allow to float.				
4	PGD1	Power good signal output for $V_{OUT1}$ . Open drain output pulls low when $V_{OUT1}$ is below ( $V_{OUT1(NOM)}$ -12%).				
5	GND	Ground.				
6	PGD2	Power good signal output for $V_{OUT2}$ . Open drain output pulls low when $V_{OUT2}$ is below ( $V_{OUT2(NOM)}$ -12%).				
7	EN2	Active high enable control. Connect to IN if not being used. Do not allow to float.				
8	ADJ2	Regulator #2 sense input. Used for sensing the output voltage for power good and under-voltage, and to set the output voltage as follows (refer to application circuit on page 1): $V_{OUT(MAX)} = 3.3V$ for $V_{IN} = 12V$ , 1.8V for $V_{IN} = 5V$ . $V_{OUT(MAX)} = 3.3V$ for $V_{IN} = 12V$ , 1.8V for $V_{IN} = 5V$ .				
9	DRV2	Output of regulator #2, output impedance ~ 1k $\Omega$ . Drives the gate of an N-channel MOSFET to maintain V <sub>OUT2</sub> set by R3 and R4.				
10	IN	+5V or +12V supply.				



Block Diagram





#### Applications Infomation

#### **Theory Of Operation**

The SC2738 dual linear FET controller provides a simple way to drive two N-channel MOSFETs to produce tightly regulated output voltages from one or two available, higher, supply voltages. It takes its power from either a 5V or 12V supply, drawing typically 500µA while operating.

It contains an internal bandgap reference which is compared to the output voltages via resistor dividers. These resistor dividers are external and user selectable . Depending upon the input voltage used for the device, the drive pin (DRV1, DRV2) can pull up to a guaranteed minimum of 6.6V (from 12V supply) or 4.7V (from 5V supply). Thus the device can be used to regulate a large range of output voltages by careful selection of the external MOSFETs (see component selection, below).

The SC2738 includes an active high enable control (EN1, EN2) for each output. If this pin is pulled low, the related drive pin is pulled low, turning off the N-channel MOSFET. If the pin is pulled up to  $1.8V \le V_{\text{EN}} \le V_{\text{IN}}$ , the drive pin will be enabled. This pin should not be allowed to float.

Each output has a power good output (PGD1, PGD2) which are open drain outputs that pull low if the related output is below the power good threshold (-12% of the programmed output voltage typical, -6% typical at start-up). The power good circuitry is active if the device is enabled, regardless of the state of the over current latch. The power good circuitry is not active if that particular output is disabled.

Also included for each output is an overcurrent protection circuit that monitors the output voltage. If the output voltage drops below 50% (typ.) of nominal, as would occur during an overcurrent or short condition, the device will pull the drive pin low and latch off. The device will need to have the power supply or enable pin toggled to reset the latch condition. Each output latches independently (i.e. if one output latches off, the other output will function normally).

#### **Drive Outputs and Soft Start**

The drive outputs for each output are source and sink capable. The sink current is typically 0.8mA at 5V in (1mA at 12V in). The source current is typically 2mA at 5V in

and 3.75mA at 12V in during normal operation. The high side drive voltage is generated from  $V_{\rm IN}$  by a 7V (nominal) low dropout regulator, thus at 12V in, 6.9V is available and at 5V in, 4.85V is available (since the LDO will be in dropout).

At start-up, the source current available from the drive pins is limited to  $10\mu$ A (typical) until the power good threshold is reached, at approximately 6% below nominal output voltage. At this point the full drive capability is enabled. With this constant current source at start-up, it is a simple matter to use a small capacitor on the drive pin to slow this rate of rise. The rate of rise of the **drive pin** voltage will be:

$$\frac{\mathrm{dV}_{\mathrm{DRV}}}{\mathrm{dt}} = \frac{\mathrm{I}_{\mathrm{DRV}}}{\mathrm{C}_{\mathrm{SS}}} \ \mathrm{V/s}$$

A 10nF soft start capacitor will give a 1ms **output** rise time for  $V_{IN} = 12V$  and  $V_{OUT} = 1.05V$ , for example. The output rise time will of course depend upon the gate threshold of the MOSFET being used. Please refer to the Output Rise Time chart on Page 12 showing typical output rise times. For very low ESR output capacitors ( $<5m\Omega$ ) **and** very high soft start capacitance (>100nF), it may be necessary to add a resistor in series with the soft start capacitor to ensure stability. Generally, however, this resistor is not required, as this is a very unlikely situation.

The soft start capacitance does not adversely affect transient response since the drive current capability is 200 times higher once the device has started.

#### **OCP and Power Supply Sequencing**

The SC2738 has output under-voltage protection that looks at a particular output to see if it is a) less than 50% (typical) of it's nominal value and b)  $V_{DRV}$  for that output is within 350mV (typical) of maximum. If both of these criteria are met, there is a 50µs (typical) delay and then the output is shut down. This provides inherent immunity to UV shutdown at start-up (which may occur while the output capacitors are being charged) since  $V_{DRV}$  has a very slow rate of rise with  $I_{DRV}$  limited to 10µA.

At start-up, it is necessary to ensure that the power supplies and enables are sequenced correctly to avoid erroneous latch-off. For UV latch-off not to occur at startup due to sequencing issues, the key is that the voltage



#### Applications Infomation (Cont.)

supplied to the MOSFET drain should be greater than the output under-voltage threshold when that output is enabled. This assumes that the drop through the pass MOSFET is negligible. If not, then this drop needs to be taken into account also since:

$$V_{OUT} = V_{DRAIN} - (I_{OUT} \times R_{DS(ON)}).$$

If the supply to the SC2738 IN pin comes up before the supply to the MOSFET drain, then that output should be enabled as the supply to the MOSFET drain is applied - the Power Good signal for this rail would be ideal. If the power supply to the MOSFET drain comes up before the power supply to the SC2738 IN pin, then the output can either be enabled with the supply to the IN pin or afterwards. Please see the example below.

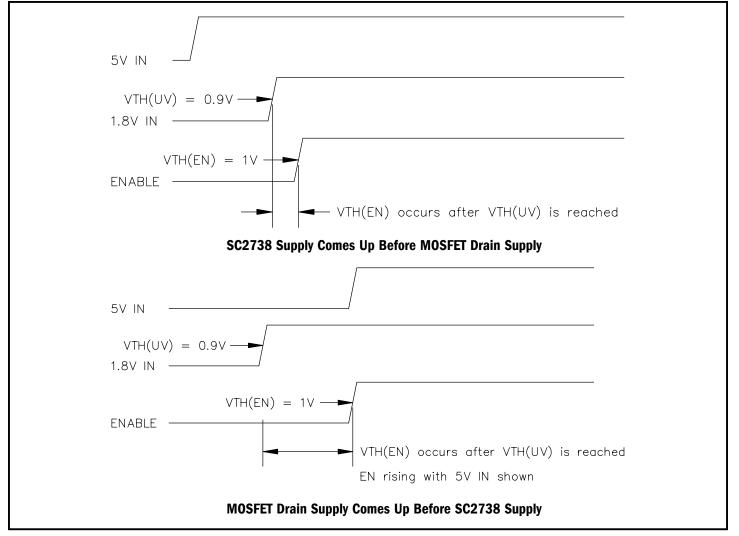
**Example:** SC2738 powered from 5V, output 1 powered from 1.8V set for 1.5V out, output 2 not shown for

simplicity. Worst case under-voltage threshold is 60% (over temperature) of 1.5V, or 0.9V. The typical enable threshold is ~1V. See Figure 1 below.

#### **Component Selection**

**Output Capacitors:** low ESR capacitors such as Sanyo POSCAPs or Panasonic SP-caps are recommended for bulk capacitance, with ceramic bypass capacitors for decoupling high frequency transients.

**Input Capacitors:** placement of low ESR capacitors such as Sanyo POSCAPs or Panasonic SP-caps at the input to the MOSFET ( $V_{DRAIN}$ ) will help to hold up the power supply during fast load changes, thus improving overall transient response. If  $V_{DRAIN}$  is located at the bulk capacitors for the upstream voltage regulator, additional capacitance may not be required. In this case a 0.1µF ceramic capacitor will suffice. The input supply to the SC2738 should be bypassed with a 0.1µF ceramic capacitor.



#### Figure 1: Power Supply Sequencing



## Applications Infomation (Cont.)

**MOSFETs:** very low or low threshold N-channel MOSFETs are required. Selecting FETs rated for V<sub>GS</sub> of 2.7V or 4.5V will depend upon the available drive voltage (6.9V from 12V in or 4.85V from 5V in), the output voltage and output current. For the device to work under all operating conditions, a maximum R<sub>DS(ON)</sub> must be met to ensure that the output will never go into dropout:

 $R_{\text{DS(ON)(MAX)}} = \frac{V_{\text{IN}(\text{MIN})} - V_{\text{OUT}(\text{MAX})}}{I_{\text{OUT}(\text{MAX})}} \quad \Omega$ 

Note that  $R_{_{DS(ON)}}$  must be met at all temperatures and at the minimum  $V_{_{GS}}$  condition.

**Setting The Output Voltage:** the adjust pins connect directly to the inverting input of the error amplifiers, and the output voltage is set using external resistors (please refer to the Typical Application Circuit on page 1).

Using output 1 as an example, the output voltage can be calculated as follows:

$$V_{OUT} = 0.5 \bullet \left(1 + \frac{R1}{R2}\right)$$

The input bias current for the adjust pin is so low that it can be safely ignored. To avoid picking up noise, it is recommended that the total resistance of the feedback chain be less than  $100k\Omega$ .

Please see Table 1 on this page for recommended resistor values for some standard output voltages. All resistors are 1%, 1/10W.

The maximum output voltage that can be obtained from each output is determined by the input supply voltage and the  $R_{DS(ON)}$  and gate threshold voltage of the external MOSFET. Assuming that the MOSFET gate threshold voltage is sufficiently low for the output voltage chosen and the worst-case drive voltage,  $V_{OUT(MAX)}$  is given by:

 $V_{\text{OUT}(\text{MAX})} = V_{\text{DRAIN}(\text{MIN})} - I_{\text{OUT}(\text{MAX})} \bullet R_{\text{DS}(\text{ON})(\text{MAX})}$ 

VOUT (V)	R1 or R3 (kΩ)	R2 or R4 (k $\Omega$ )
1.05	11.0	10.0
1.2	14.0	10.0
1.5	20.0	10.0
2.5	45.3	11.3
3.3	63.4	11.3

#### Table 1: Recommended Resistor Values For SC2738

#### **Design Example**

Goal:  $1.5V\pm5\%$  static and  $\pm7\%$  transient @ up to 4A from  $2.5V\pm5\%$  and  $5V\pm5\%$ 

Total window for DC error and ripple is  $\pm 75$ mV. Total window for transient is  $\pm 105$ mV.

Since this device is linear, and assuming that it has been designed to not ever enter dropout, we do not have ripple on the output.

The DC error for this output is the sum of:

 $V_{RFF}$  accuracy = ±3.5% = ±52.5mV

Feedback chain tolerance =  $\pm 1\%$  =  $\pm 15mV$ 

Load regulation =  $\pm 0.25\%$  =  $\pm 3.8$ mV

Set resistors per Table 1 should be 20.0k $\Omega$  (top) and 10.0k $\Omega$  (bottom).

Total DC error =  $\pm 4.75\%$  = 71.3mV

This leaves  $\pm 2.25\% = 33.7$ mV for the load transient ESR spike, therefore:

$$\mathsf{R}_{\mathsf{ESR}(\mathsf{MAX})} = \frac{33.7\mathsf{mV}}{4\mathsf{A}} = 8.4\mathsf{m}\Omega$$

Bulk capacitance required is given by:

$$C_{\text{BULK}(\text{MIN})} = \frac{dI \bullet t}{dV} \mu F$$

Where dl is the maximum load current step, t is the maximum regulator response time and dV is the allowable voltage droop. Therefore with dl = 4A, t =  $1\mu$ s, and dV = 33.7mV:



# Applications Infomation (Cont.)

$$C_{\text{BULK}(\text{MIN})} = \frac{4 \bullet 1 \bullet 10^{-6}}{33.7 \bullet 10^{-3}} = 119 \mu F$$

So if we use 1% V<sub>out</sub> set resistors we would select 2 x >100µF, 18m $\Omega$  POSCAPs for output capacitance (which assumes that local ceramic bypass capacitors will absorb the balance of the (9 - 8.4)m $\Omega$  ESR requirement - otherwise 15m $\Omega$  capacitors should be used).

If we use 0.1% set resistors, then the total DC error becomes  $\pm 3.85\% = \pm 57.8$ mV, leaving  $\pm 3.15\% = 47.2$ mV for the ESR spike. In this case:

 $R_{\text{ESR}(\text{MAX})} = \frac{47.2 mV}{4A} = 11.8 m\Omega \text{ and}$ 

$$C_{\text{BULK}(\text{MIN})} = \frac{4 \bullet 1 \bullet 10^{-6}}{47.2 \bullet 10^{-3}} = 85 \mu F$$

So for 0.1% resistors we could use 1 x 100µF,  $12m\Omega$  POSCAPs for output capacitance.

The input capacitance needs to be large enough to stop the input supply from collapsing below -5% (i.e. the design minimum) during output load steps. If the input to the pass MOSFET is not local to the supply bulk capacitance then additional bulk capacitance may be required.

MOSFET selection: since the input voltage to the SC2738 is  $5V\pm5\%$ , the minimum available gate drive is:

$$V_{GS} = (4.4 - 1.575) = 2.825V$$

So a MOSFET rated for  $V_{GS}$  = 2.7V will be required, with an  $R_{DS(ON)(MAX)}$  (over temp.) given by:

$$R_{\text{DS(ON)MAX})} = \frac{(V_{\text{IN(MIN)}} - V_{\text{OUT}})}{I_{\text{OUT(MAX)}}} = \frac{(2.375 - 1.5)}{4} = 22m\Omega$$

Obviously, if a 12V rail is available to power the SC2738, the number of FET options increases dramatically.

#### Layout Guidelines

The advantages of using the SC2738 to drive external MOSFETs are a) that the bandgap reference and control circuitry are in a die that does not contain high power dissipating devices and b) that the device itself does not need to be located right next to the power devices. Thus very accurate output voltages can be obtained since changes due to heating effects will be minimal.

The  $0.1\mu F$  bypass capacitor should be located close to the supply (IN) and GND pins, and connected directly to the ground plane.

The feedback resistors should be located at the device, with the sense line from the output routed from the load (or top end of the droop resistor if passive droop is being used) directly to the feedback chain. If passive droop is being used, the droop resistor should be located right at the load to avoid adding additional unplanned droop.

Sense and drive lines should be routed away from noisy traces or components.

For very low input to output voltage differentials, the input to output / load path should be as wide and short as possible. Where greater headroom is available, wide traces may suffice.

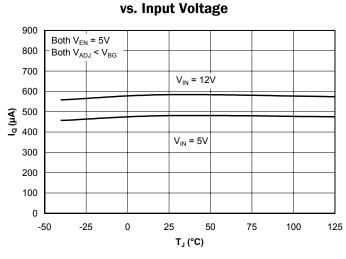
Power dissipation within the device is practically negligible, thus requiring no special consideration during layout. The MOSFET pass devices should be laid out according to the manufacturer's guidelines for the power being dissipated within them.





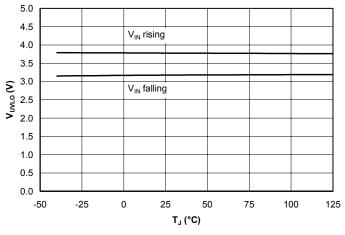
# POWER MANAGEMENT Typical Characteristics

#### **Quiescent Current vs. Junction Temperature**



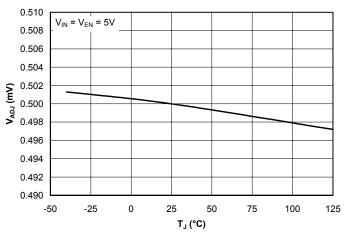
Start Threshold vs.

Junction Temperature

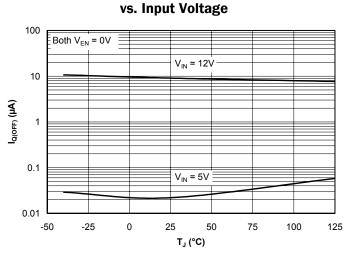


**Reference Voltage vs.** 

**Junction Temperature** 

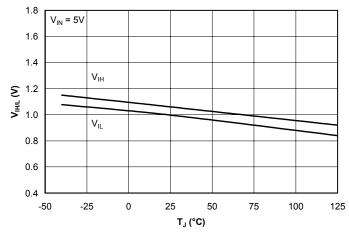


Standby Current vs. Junction Temperature



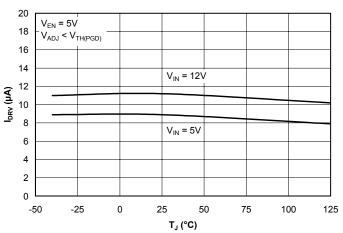
Enable Input Threshold Voltage

vs. Junction Temperature



Drive Pin Output Current (Sourcing) at Startup

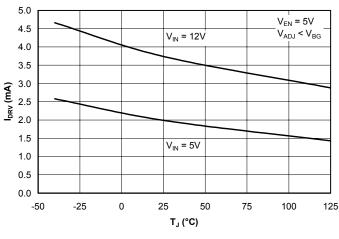
vs. Junction Temperature vs. Input Voltage





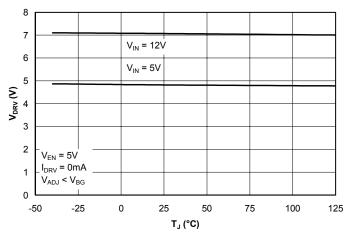
# Typical Characteristics (Cont.)

#### Drive Pin Output Current (Sourcing) vs. Junction Temperature vs. Input Voltage



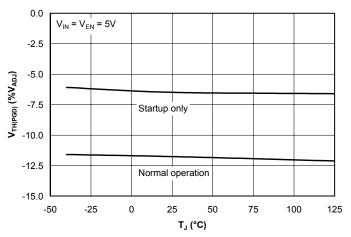
#### Drive Pin Output Voltage (Full On) vs.

#### Junction Temperature vs. Input Voltage

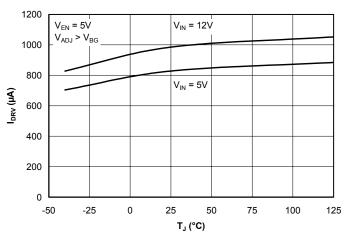


Power Good Threshold vs.

**Junction Temperature** 

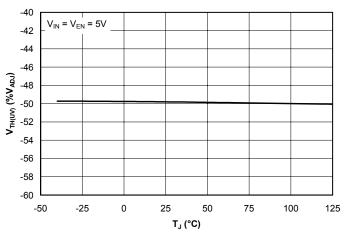


Drive Pin Output Current (Sinking) vs. Junction Temperature vs. Input Voltage



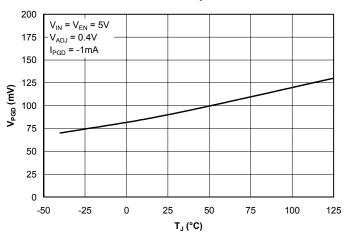
#### **Under Voltage Trip Threshold**

vs. Junction Temperature



#### **Power Good Logic Low Output Voltage**

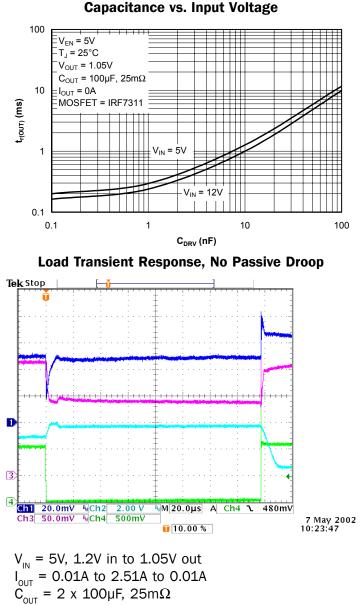
#### vs. Junction Temperature





# Typical Characteristics (Cont.)

#### Output Rise Time At Startup vs. Soft Start



Trace 1:  $V_{\text{OUT}}$ , 20mV/div., offset 1V Trace 2:  $V_{\text{DRV}}$ , 2V/div. Trace 3: 1.2V in, 50mV/div., offset 1V Trace 4: load FET drain Timebase: 20µs/div. Load rise/fall times  $\ge$  35A/µs

Load Transient Response, With Passive Droop  $\frac{1}{1000\%} = 5V, 1.2V \text{ in to } 1.05V \text{ out} \\ l_{\text{out}} = 0.01A \text{ to } 2.51A \text{ to } 0.01A \\ C_{\text{out}} = 1 \times 100 \mu\text{F}, 25m\Omega$ 

 $R_{DROOP} = 20m\Omega$ 

- Trace 1: V<sub>out</sub>, 20mV/div., offset 1V
- Trace 2: not connected
- Trace 3: 1.2V in, 50mV/div., offset 1V

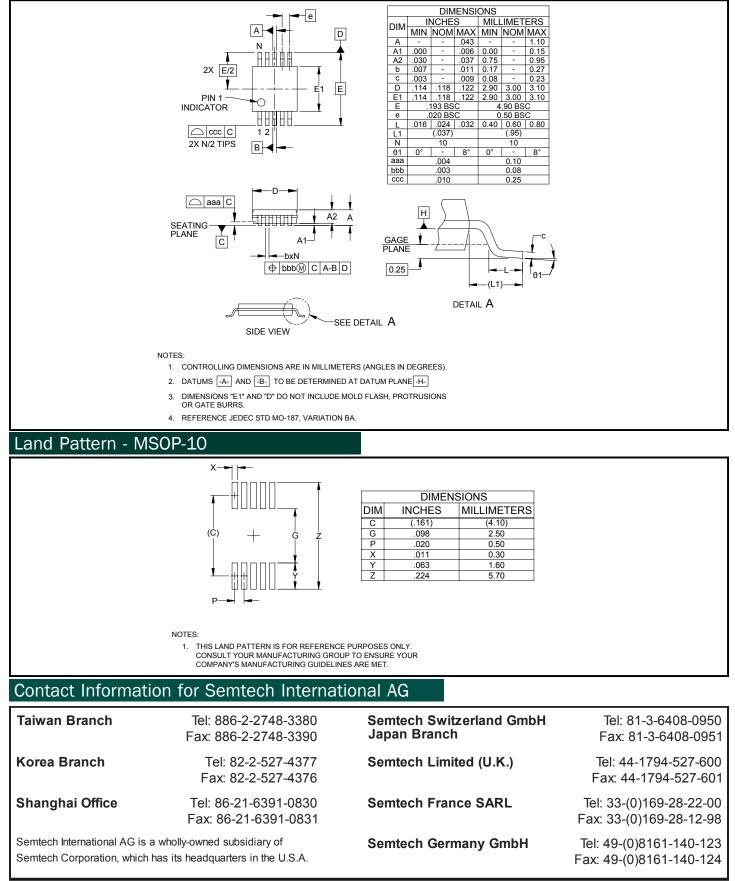
Trace 4: load FET drain

Timebase: 20µs/div.

Load rise/fall times  $\ge$  35A/µs



#### **Outline Drawing - MSOP-10**



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